


<b>Search Notes</b>  	<b>Application/Control No.</b>  10561487	<b>Applicant(s)/Patent Under Reexamination</b>  DRAYNA ET AL.
	<b>Examiner</b>  SANDRA WEGERT	<b>Art Unit</b>  1647

SEARCHED			
Class	Subclass	Date	Examiner
NONE			

SEARCH NOTES		
Search Notes	Date	Examiner
STIC: SEQ ID NO: 33. PLEASE SEE SEQUENCE SEARCH RESULTS IN SCORE	7/10/08	SLW
INVENTORS, PALM, EAST	7/22/08	SLW
EAST-KEYWORDS, ALL DATABASES	3/12/09	SLW
NPL-SEE PRINTOUT		
PARENT APPS-REFS CHECKED		
STIC: SEQ ID NO: 33. PLEASE SEE SEQUENCE SEARCH RESULTS IN SCORE. INVENTORS, PALM, EAST. EAST-KEYWORDS, ALL DATABASES. Pubmed-SEE PRINTOUT.		
Patentability Conference. Confer with QAS, 3/12/09	2/26/09	SLW

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	STIC: SEQ ID NO: 33. PLEASE SEE SEQUENCE SEARCH RESULTS IN SCORE. INVENTORS, PALM, EAST. EAST-KEYWORDS, ALL DATABASES. Pubmed-SEE PRINTOUT.	3/12/09	SLW

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Examiner, Art Unit 1647